

## WNM6001

## Single N-Channel, 60V, 0.50A, Power MOSFET

V <sub>DS</sub> (V)	Rds(on) (Ω)			
60	1.4@ V <sub>GS</sub> =10V			
60	1.7@ V <sub>GS</sub> =4.5V			
ESD Rating:2000V HBM				

# **Descriptions**

The WNM6001 is N-Channel enhancement MOS Field Effect Transistor. Uses advanced trench technology and design to provide excellent  $R_{\text{DS }(\text{ON})}$  with low gate charge. This device is suitable for use in DC-DC conversion, power switch and charging circuit. Standard Product WNM6001 is Pb-free and Halogen-free.

### **Features**

- Trench Technology
- Supper high density cell design
- Excellent ON resistance for higher DC current
- Extremely Low Threshold Voltage
- Small package SOT-23

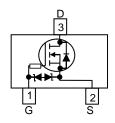
# **Applications**

- Driver for Relay, Solenoid, Motor, LED etc.
- DC-DC converter circuit
- Power Switch
- Load Switch
- Charging

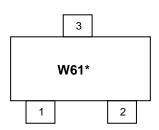
### Http//:www.sh-willsemi.com



**SOT-23** 



# Pin configuration (Top view)



W61 = Device Code \* = Month (A~Z) Marking

# **Order information**

Device	Package	Shipping
WNM6001-3/TR	SOT-23	3000/Reel&Tape



# **Absolute Maximum ratings**

Parameter		Symbol	10 s	Steady State	Unit
Drain-Source Voltage		$V_{DS}$	60		V
Gate-Source Voltage		$V_{GS}$	±20		V
Continuous Drain Current ad	T <sub>A</sub> =25°C	-	0.50	0.44	Α
Continuous Diam Current	T <sub>A</sub> =70°C	- I <sub>D</sub>	0.40	0.35	A
Maximum Power Dissipation ad	T <sub>A</sub> =25°C	0	0.69	0.53	W
Maximum Power Dissipation	T <sub>A</sub> =70°C	P <sub>D</sub>	0.44	0.34	٧٧
Continuous Drain Current bd	T <sub>A</sub> =25°C	l <sub>D</sub>	0.47	0.42	۸
Continuous Drain Current	T <sub>A</sub> =70°C		0.38	0.33	Α
Maying In Dispination bd	T <sub>A</sub> =25°C	P <sub>D</sub>	0.60	0.47	14/
Maximum Power Dissipation bd	T <sub>A</sub> =70°C		0.39	0.30	W
Pulsed Drain Current <sup>c</sup>		I <sub>DM</sub>	1.0		А
Operating Junction Temperature		TJ	-55 to 150		°C
Lead Temperature		$T_L$	260		°C
Storage Temperature Range		T <sub>stg</sub>	-55 to 150		°C

# Thermal resistance ratings

Parameter		Symbol	Typical	Maximum	Unit
Junction-to-Ambient Thermal Resistance a	t ≤ 10 s	$R_{\theta JA}$	140	180	
	Steady State		176	232	1
Junction-to-Ambient Thermal Resistance b	t ≤ 10 s	<u> </u>	165	205	°C/W
	Steady State	$R_{\theta JA}$	198	261	
Junction-to-Case Thermal Resistance	Steady State	$R_{ heta JC}$	100	120	

- a Surface mounted on FR-4 Board using 1 square inch pad size, 1oz copper
- b Surface mounted on FR-4 board using minimum pad size, 1oz copper
- c Pulse width<380µs
- d Maximum junction temperature T<sub>J</sub>=150°C.

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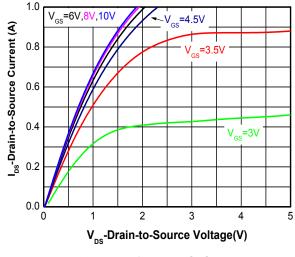
# Electronics Characteristics (Ta=25°C, unless otherwise noted)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit	
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250uA	60			V	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =60V, V <sub>GS</sub> = 0V			1	uA	
Gate-to-source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> =±20V			±5	uA	
ON CHARACTERISTICS							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}$ , $I_D = 250uA$	0.8	1.3	2	V	
D. c. b. c	Б	$V_{GS} = 10V, I_D = 0.5 A$		1.4	2.0		
Drain-to-source On-resistance b, c	R <sub>DS(on)</sub>	V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 0.2A		1.7	2.6	Ω	
Forward Transconductance	<b>g</b> FS	V <sub>DS</sub> =15V, I <sub>D</sub> =0.25A		0.42		S	
CAPACITANCES, CHARGES	-		1		•	•	
Input Capacitance	C <sub>ISS</sub>	$V_{GS} = 0 V$ ,		23.37			
Output Capacitance	Coss	f = 1.0 MHz,		7.33		pF	
Reverse Transfer Capacitance	C <sub>RSS</sub>	V <sub>DS</sub> = 25V		5.2			
Total Gate Charge	Q <sub>G(TOT)</sub>	V 40.V		1.2			
Threshold Gate Charge	Q <sub>G(TH)</sub>	$V_{GS} = 10 \text{ V},$ $V_{DD} = 30 \text{ V},$		0.15		nC	
Gate-to-Source Charge	$Q_{GS}$	$V_{DD} = 30 \text{ V},$ $I_{D} = 0.37 \text{A}$		0.21			
Gate-to-Drain Charge	$Q_{GD}$	ID =0.37 A		0.12			
SWITCHING CHARACTERISTICS							
Turn-On Delay Time	td(ON)			7.6			
Rise Time	tr	V <sub>DD</sub> =30V, I <sub>D</sub> =0.2A,		5.1			
Turn-Off Delay Time	td(OFF)	$V_{GEN}=10V,R_{G}=10 \Omega$		24.6		ns	
Fall Time	tf			10			
BODY DIODE CHARACTERISTICS							
Forward Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V, I <sub>S</sub> =0.3A		0.9	1.5	V	

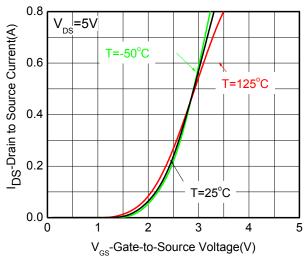
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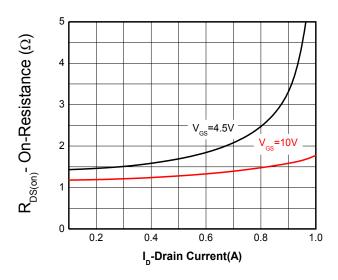
# Typical Characteristics (Ta=25°C, unless otherwise noted)



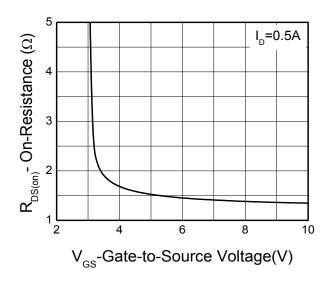
**Output characteristics** 



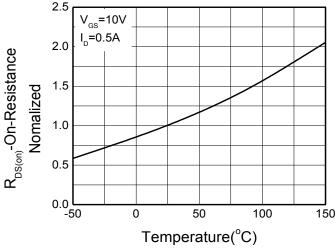
**Transfer characteristics** 



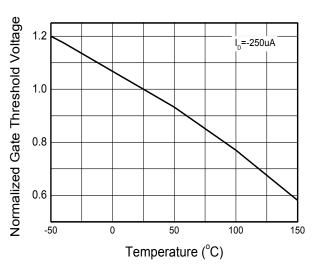
On-Resistance vs. Drain current



On-Resistance vs. Gate-to-Source voltage

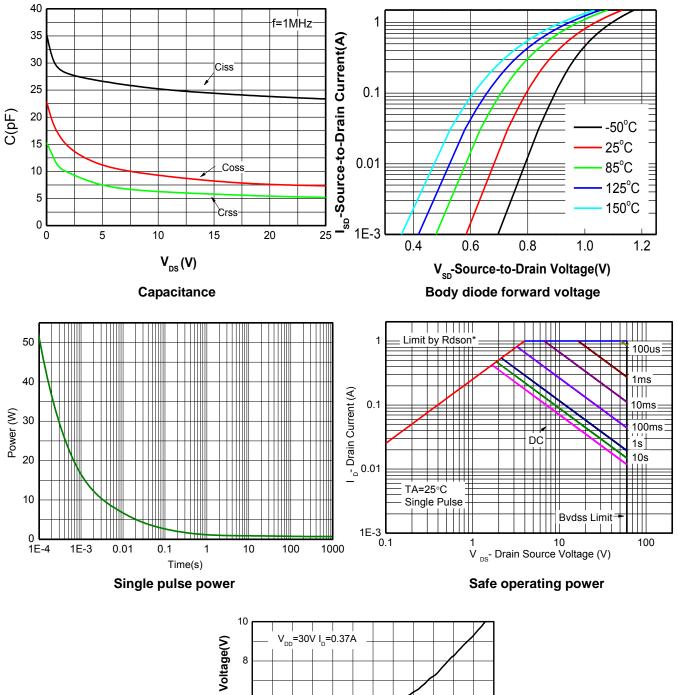


On-Resistance vs. Junction temperature



Threshold voltage vs. Temperature



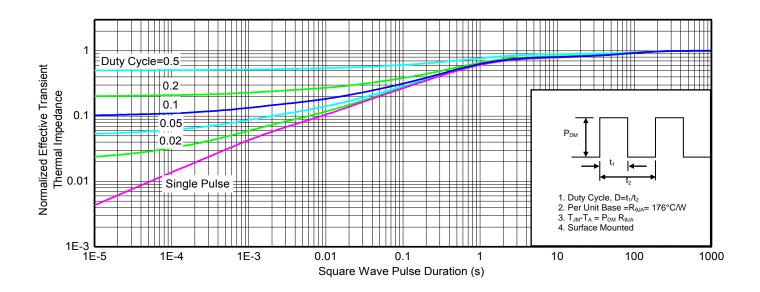


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**Gate Charge Characteristics** 

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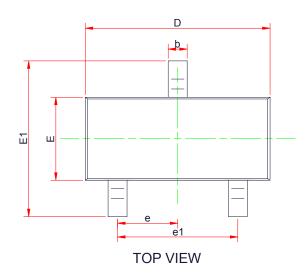
**Transient thermal response (Junction-to-Ambient)** 

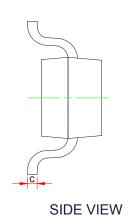
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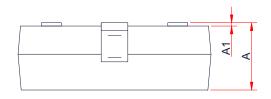


# Package outline dimensions

# **SOT-23**







SIDE VIEW

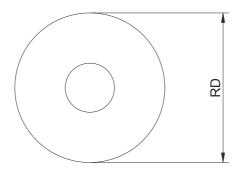
Symbol	Dimensions in Millimeters					
	Min.	Тур.	Max.			
A	0.89	1.10	1.30			
A1	0.00	-	0.10			
b	0.30	0.43	0.55			
С	0.05	-	0.20			
D	2.70	2.90	3.10			
E	1.15	1.33	1.50			
E1	2.10	2.40	2.70			
е		0.95 Тур.				
e1	1.70	1.90	2.10			

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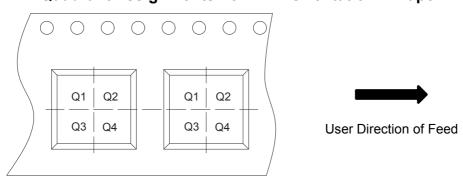
# TAPE AND REEL INFORMATION

# **Reel Dimensions**



# Tape Dimensions H H H H A

# **Quadrant Assignments For PIN1 Orientation In Tape**



RD	Reel Dimension	<b>☑</b> 7inch	13inch		
W	Overall width of the carrier tape	₹ 8mm	☐ 12mm	☐ 16mm	
P1	Pitch between successive cavity centers	☐ 2mm	<b>✓</b> 4mm	8mm	
Pin1	Pin1 Quadrant	□ Q1	□ Q2	<b>▼</b> Q3	□ Q4